

Notice of References Cited	Application/Control No. 10/790,823	Applicant(s)/Patent Under Reexamination YOSHIDA, HISASHI	
	Examiner (Nancy) Thanh-Nhan P. Nguyen	Art Unit 2871	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,624,860	09-2003	Narutaki et al.	349/106
	B	US-2003/0020852	01-2003	Chang et al.	349/110
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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